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## U.S. PATENT DOCUMENTS

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	В	US-6311892	11-2001	O'Callaghan et al	235/375
	С	US-5737438	04-1998	Zlotnick et al	382/101
	D	US-6189702	02-2001	Bonnet	209/651
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	F	US-6360947	03-2002	Knowles et al	235/462.01
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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